Continuous Mott Transition in Moiré Semiconductors: Role of Long-Wavelength Inhomogeneities

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Recent experiments in moiré transition metal dichalcogenide materials have reported the observation of a continuous bandwidth-tuned transition from a metal to a paramagnetic Mott insulator at a fixed filling of one electron per moiré unit cell. The electrical transport measurements reveal a number of puzzling features that are seemingly at odds with the theoretical expectations of an interaction-induced, but disorder-free, bandwidth-tuned metal-insulator transition. In this Letter, we include the effects of long-wavelength inhomogeneities, building on the results for a continuous metal-insulator transition at fixed filling in the clean limit. We examine the effects of mesoscale inhomogeneities near the critical point on transport using the framework of random resistor networks, highlighting the salient differences from a simple percolationbased picture. We place our results in the context of recent and ongoing experiments.

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Introduction.—Electrical transport properties of metals and insulators at low temperature are vastly different. The finite, but small, low-temperature resistance in conventional metals with weak disorder is due to elastic scattering off impurities. On the other hand, electrical transport in insulators with a finite charge gap is nearly frozen out. Across a continuous metal-insulator transition (MIT), the theoretical mechanism leading to the dramatic suppression of the electrical conductivity is a question of fundamental interest, made especially difficult by the complex interplay of interaction and disorder effects. Recent experimental advances in tunable moiré materials have led to the demonstration of a bandwidth-tuned continuous quantum phase transition (QPT) between a metal and an interactioninduced Mott insulator at a fixed (commensurate) filling [\[1,](#page-4-0)[2](#page-4-1)].

We focus here on one of these experiments [[2\]](#page-4-1), which studied a continuous MIT in a transition metal dichalcogenide (TMD) heterobilayer as a function of an external displacement field at half filling. Approaching the transition from the insulating side, the charge gap vanishes continuously and is not associated with long-range magnetism (at least down to 5% of the Curie-Weiss scale). Moreover, the spin susceptibility evolves smoothly across the MIT, suggesting that the Mott insulator has an abundance of low-energy spinful excitations and displays a "Pomeranchuk" effect as a function of increasing temperature. The temperature-dependent resistivity traces exhibit beautiful scaling collapse into two sets of insulating and metallic-like curves, with the possible exception of the immediate vicinity of the critical point suggesting the important role played by inhomogeneities. One possible theory [\[3\]](#page-4-2) that can help to explain much of this data is associated with the transition from a Fermi-liquid metal to a paramagnetic Mott insulator with a Fermi surface of electrically neutral spinons [[4\]](#page-4-3). Across such a QPT, the spin susceptibility evolves smoothly as the electronic Fermi surface morphs into the spinon Fermi surface, while the quasiparticle residue and charge gap vanish continuously upon approaching the critical point from either side. A number of complementary theoretical approaches have also been used to analyze other aspects of MIT and insulating regimes [[5](#page-4-4)–[9](#page-4-5)] in this system. The role of disorder has been analyzed starting from a different point of view across (but not necessarily continuous and bandwidth-tuned) MITs [\[10](#page-4-6)–[13\]](#page-4-7); see also Refs. [\[14](#page-4-8)–[16\]](#page-4-9).

Despite the broad agreement between the experiment and theory, there are a number of mysteries associated with the transport measurements, especially when placed in the context of the theory for a continuous metal to paramagnetic Mott insulator transition. In the absence of microscopic inhomogeneities, the theoretical expectation for the resistivity evolution as a function of the external tuning parameter and temperature is as shown in Figs. [1\(a\)](#page-1-0) and [1\(b\).](#page-1-0) At asymptotically low temperatures, the resistivity is accompanied by a universal "jump" of magnitude, $\rho_c = \mathcal{R}\rho_Q(\rho_Q = h/e^2)$, across the MIT. \mathcal{R} here is a universal number whose exact numerical value is determined by the strongly coupled field theory describing the critical point [[4](#page-4-3),[17](#page-4-10),[18](#page-4-11)]. Moreover, as a function of increasing temperature, all resistance traces should cross at a single point [\[17\]](#page-4-10). On the other hand, the experiments reveal the following anomalous features: (i) The transport data reveal no sign of a resistivity jump; instead, the lowtemperature resistance grows dramatically upon approaching the putative critical point from the metallic side

FIG. 1. (a) and (b) Theoretical expectation for resistivity evolution in the clean limit as a function of temperature (T) and tuning parameter (g) , across a bandwidth-tuned MIT at $g = g_c$. There is a universal jump in the resistivity, $\rho_c = \mathcal{R}\rho_o$, at $g = g_c$. For $T > 0$, the resistivity traces cross at a single point. (c) Experimental results for the resistance as a function of outof-plane electric field, E. For $T > 0$, they exhibit multiple crossing points [[2\]](#page-4-1). (d) At the critical field $E = E_c$, the resistance exhibits an unusual power-law behavior (black dashed line) $R \sim T^{-\alpha}$ with $\alpha \approx 1.2$.

[Fig. [1\(c\)](#page-1-0)]. (ii) The resistivity traces exhibit multiple crossings at different values of the tuning parameter as a function of increasing temperatures [Fig. [1\(c\)\]](#page-1-0). (iii) The normalized sheet resistance, $R(T)/R_c(T)$, exhibits scaling collapse into two families of mirror symmetric curves, where $R_c(T)$ represents an unusual power-law resistance at the critical point [Fig. [1\(d\)](#page-1-0)]. It is natural to ask if resolving these discrepancies between theory and experiment requires an entirely new starting point.

In this Letter, we will demonstrate that all of the unexpected features associated with electrical transport are likely tied to the effects of mesoscale inhomogeneities near the continuous MIT. We do not describe the microscopic origin of such inhomogeneities here, which likely arise due to a variety of reasons including some combination of Coulomb impurities, twist-angle disorder, etc. In our model, the sample consists of "puddles," with a characteristic mean bandwidth defined locally within each puddle [\[23\]](#page-5-0). Electrical transport is then best described in terms of a random network of such puddles. However, as we explain below, a naive bond-percolation picture in terms of only metallic and insulating links is insufficient to account for the experimental phenomenology. The intrinsic correlation effects that lead to additional temperature-dependent fractions of puddles with "critical" resistance $[\rho_c \sim O(h/e^2)]$ lead to a modified percolative transition.

Model.—Let us first consider a simplified picture $T = 0$. We consider an external parameter $g(\sim$ Bandwidth/Interaction) driving the QPT across $g = g_c$. As a result of the long-wavelength disorder, the system is effectively described by a network of resistors corresponding to either metallic $(g > g_c)$ or insulating $(g < g_c)$ puddles. For a given *mean* value of the tuning parameter, g_0 , we assume that the distribution of resistors is given by $P_{\sigma}(g, g_0) = e^{-(g-g_0)^2/\sigma^2}/\sqrt{\pi \sigma^2}$, where σ represents a characteristic disorder strength. Henceforth, g will denote a unitless parameter (i.e., $g/\sigma \rightarrow g$). At $T = 0$, the metallic resistors are assumed to have a small residual resistance, $\rho_m \ll \rho_o$, due to weak elastic impurity scattering, while the insulating resistors have infinite resistance [Fig. [1\(a\)\]](#page-1-0). The system is then effectively described by bond percolation, and the conductance of this random resistor network (RRN) can be computed using the transfer-matrix method [\[19,](#page-4-12)[20](#page-4-13)].

Next, we turn to the role of a finite temperature, which is incorporated within our model via two distinct mechanisms. For the insulating puddles, we assume that their resistance has an activated form, $\rho = \rho_c e^{\Delta_g/2k_B T} \gtrsim \rho_o$, where $\Delta_g =$ $\Delta_0|g - g_c|^{vz}$ is the "local" gap size within the puddle, with a characteristic energy Δ_0 . For our numerical computations and comparison with experiments, we will assume that the puddle itself is locally described by the clean theory associated with a QPT from a metal to a paramagnetic Mott insulator with a spinon Fermi surface; the associated correlation length exponent, $\nu \sim 0.67$; and the dynamical exponent, $z = 1$ [\[4\]](#page-4-3). Additionally, as a function of increasing temperature, the system will crossover into the quantum-critical (QC) regime, which is controlled by the fixed point associated with the clean theory [Fig. [2\(a\)\]](#page-2-0). As noted earlier, transport in this regime is dominated by critical resistors, $\rho_c = \mathcal{R}\rho_Q$, and the volume fraction of puddles with a critical resistance, f_{critical} , is controlled by the width of the QC fan at a given temperature [Fig. [2\(a\)\]](#page-2-0). Once we include both temperature-dependent effects, the numerical calculations will lead to a remarkable agreement with the experimental phenomenology.

To understand how the metallic, insulating, and critical puddles contribute to the current-carrying paths, let us consider two representative points, (q_0, T) , on a simplified phase diagram [Fig. [2\(a\)](#page-2-0)]. We show a snapshot of a typical percolating current path (green network) in Fig. [2\(b\)](#page-2-0) for the point labeled ①, at low temperature and deep in the metallic regime, which involves almost entirely metallic resistors (blue) and practically no critical resistors (red). In this low-temperature limit, the total fraction of resistors, $(f_{\text{critical}}+f_{\text{metal}})\approx f_{\text{metal}} \gg p_c$, where p_c is the percolation threshold on the triangular lattice. We note that the (bond) percolation threshold is defined as the fraction of connected bonds in a network, at which an infinitely large cluster forms and the percolation sets in [[21](#page-4-14)]. Thus, deep in this metallic regime, the critical resistors do not play any significant role. We now turn to the point labeled ②, a point at high temperature in the QC regime, where we assume that $(f_{\text{critical}} + f_{\text{metal}}) \rightarrow p_c^+$ approaches the percolation threshold from above. Let us first ignore thermal

FIG. 2. (a) A simplified phase diagram for a continuous MIT showing a metallic, (Mott) insulating, and critical regime, where $T^* \sim |g - g_c|^{\nu z}$ denotes a crossover scale with ν , z, the critical exponents for the clean theory [[4\]](#page-4-3). (b) A typical snapshot of the percolating current path (green) consisting of metallic resistors (blue) for a point labeled as ①, deep in the metallic regime. (c) The percolating backbone for the point ② contains metallic and critical resistors (red). (d) For the same point ②, introducing a finite resistance due to the thermally activated resistors (light red) contributes to the percolating backbone.

activation for the insulating links. With increasing temperature, the width of the QC fan becomes larger, thereby increasing f_{critical} . Thus, the current-carrying "backbone" now inevitably contains critical resistors [Fig. [2\(c\)\]](#page-2-0). As long as these critical resistors are located at singly connected bonds along the backbone, it can lead to a significant increase in the resistance by $\sim O(\rho_0)$. If we now introduce a thermally activated contribution to the resistance due to the insulators, the current path will also include those insulating resistors with a small gap (light red) in the vicinity of the critical point [Fig. [2\(d\)](#page-2-0)]. Clearly, as one approaches the percolation threshold, the overall conductivity will be determined by the nontrivial connectivity along the backbone, which we address next using a more quantitative analysis.

Results.—We begin by presenting the evolution of the resistance across the MIT, including the finite-temperature effects (measured in units, $\tilde{T} = k_B T/\Delta_0$, where Δ_0 is a fixed-gap scale deep in the insulator). We consider a semiinfinite strip-like geometry with dimensions $L_x \times L_y \sim$ $10^5 \times 100$. The results in Fig. [3](#page-3-0) are obtained for $\rho_c =$ $5\rho_Q$ and a constant $\rho_m = 0.01\rho_Q$; we have obtained similar results for a distribution of metallic resistance values centered around a mean ρ_m . Importantly, the key differences arise depending on whether the critical resistors are included in the computation. We note that our coarse-grained percolation model ignores a number of microscopic ingredients—e.g., the explicit temperature dependence of ρ_m . However, as our analysis will show, even this simplified treatment captures the essential phenomenology near the MIT, where the dominant effect of increasing temperature is to enter the critical regime [Fig. [2\(a\)](#page-2-0)] with a large $O(\rho_o)$ resistance.

First, we consider the simplest scenario without any critical resistors, where the temperature dependence enters via thermal activation. In Fig. [3\(a\),](#page-3-0) we present the evolution of resistance as a function of g_0 at different temperatures. It is clear that at any fixed value of $g₀$, the resistance should decrease as a function of increasing temperature due to thermal activation. Importantly, in this scenario there are no crossings, unlike the experimental data. Turning next to the setup including critical resistors, we show results for resistance in Figs. [3\(b\)](#page-3-0) and [3\(c\)](#page-3-0) in the absence and presence of thermally activated insulators, respectively. The traces corresponding to $T = 0$ in both curves (violet), where $f_{\text{critical}} = 0$, are identical; the resistance diverges continuously upon approaching the percolation threshold [[21](#page-4-14)]. Within this setup, the notion of a universal resistivity jump at the MIT even at asymptotically low temperatures is ill defined. Notably, with increasing temperature, the resistance curves exhibit multiple crossing points (black arrows) just as the experimental results in Fig. [1\(c\),](#page-1-0) which is tied crucially to the presence of the critical resistors with a temperature-dependent f_{critical} [\[22\]](#page-4-15).

To understand the origin of multiple crossings, recall that p_c is determined by the *total* fraction of resistors, $(f_{critical} + f_{metal})$. At $T = 0$, f_{metal} is determined by the blue region in the top panel of Fig. $3(d)$. At finite T, $f_{\text{critical}} \sim T^{1/\nu z}$, the width of the QC fan associated with the underlying clean fixed point. Thus, at finite T , p_c is determined by the total area of the blue and red regions in the bottom panel of Fig. $3(d)$. As a function of increasing temperature, as the area of the red region increases, the position of the critical point g_0 also changes. This leads to the multiple crossing points.

Turning now to the temperature dependence of the resistance in the scenario including the thermally activated insulators, we show our results as a function of varying q_0 in Fig. [3\(e\)](#page-3-0). We identify the critical point as $g_{0,c} \sim -0.347$ (red curve) based on the following two measures. First, one can distinguish between a metallic and insulating-like response at low temperatures depending on the sign of dR/dT , with $g_{0,c}$ as an inflection point. Secondly, we can observe scaling collapse for the curves near $g_{0,c}$ onto metallic and insulating branches [inset of Fig. [3\(e\)](#page-3-0)] by considering the normalized resistance, $R(q_0, T)/R_c(T)$, as a function of T/T_0 . Here, $R_c(T)$ is the resistance at the critical field and $k_B T_0 = \Delta_0 |g_0 - g_{0,c}|^{1/z}$ represents the charge gap. We observe that the resistance in the nominally metallic low-temperature regime increases and crosses over into an insulating-like response at high temperatures, in qualitative agreement with the experimental results

FIG. 3. Evolution of the resistance for a model (a) without and (b),(c) with critical resistors. In scenario (b), the insulators have an infinite resistance, while in (c), the insulators are thermally activated. At $T = 0$ (violet), the resistance grows continuously upon approaching the bond-percolation threshold without any notion of a jump. The resistance curves in (b) and (c) cross at multiple points (black arrows). (d) The percolation threshold is determined by the total fraction, $f_{critical} + f_{metal}$, where $f_{critical}$ is determined by the typical width of the quantum critical region. The point $g = g_c$ is temperature independent, as it is defined as the critical point associated with the clean system with a well-defined "single" crossing point. The point $g = g_0$ associated with the percolation threshold varies as a function of temperature, which is reflected in the horizontal shift of the resistance curves at different temperatures. (e) The calculated temperature dependence of resistance as a function of g_0 . The black dashed line denotes the experimentally observed power law $(\sim T^{-1.2})$ $(\sim T^{-1.2})$ $(\sim T^{-1.2})$ [2] and the critical $g_{0,c} \sim -0.35$ (red; see text). The inset shows the scaling collapse for $R(T)/R_c(T)$. The color bar represents a range $-0.1 \le g_0 - g_{0,c} \le 0.04$. (f) A scaling collapse of the experimental data [\[2\]](#page-4-1) and numerical RRN results (inset), as described by the modified functional form in Eq. [\(1\)](#page-3-1). The rescaled temperature in the inset is defined as $\tilde{T} = k_B T/\Delta_0$, which lies in a range $0.1 \le \tilde{T} \le 0.17$.

[Fig. [1\(d\)](#page-1-0)]. This is a consequence of the inclusion of critical resistors along the current path at high temperatures. Remarkably, the asymptotic high-temperature power-law behavior in this scenario is also similar to the experiments, $R_c(T) \sim 1/T^{\alpha}$, with $\alpha \approx 1.2$. It is worth noting that in the scenario without thermal activation, as in Fig. [3\(b\),](#page-3-0) the asymptotic high-temperature behavior of $R_c(T) \sim 1/T^{\alpha'}$ with $\alpha' \approx 2.3$ is markedly different [[22](#page-4-15)]. Thus, the scenario where temperature affects both the fraction of critical resistors and activated insulating resistors appears to show better quantitative agreement with the experiments. To estimate the approximate disorder strength, we fit our $T =$ 0 results to the experimental result at the lowest temperature, leading to an estimated bound at $\sigma \lesssim 5$ mV/nm [[22](#page-4-15)].

Finally, let us address the behavior of transport at finite temperature near $g_{0,c}$, but on the insulating side of the critical point. If one is not situated in the immediate vicinity of the critical point, and over a small range of intermediate temperatures, the resistance is well described by the usual activated behavior. After all, this is how the charge gap is extracted in the experiment. However, for a given realization of disorder, our analysis has already shown that the current path involves insulating links (with different local gaps) that are thermally activated, as well as temperaturedependent critical resistors. The latter effect plays an important role in giving rise to the power-law envelope, $R_c(T)$, at higher temperatures. Therefore, it is natural to consider the possibility of describing the full temperature dependence of the resistance, which interpolates between the power-law temperature dependence at $g = g_{0,c}$ and an activated form deep inside the insulator, using a single function,

$$
R(g_0, T) = R_c(T) \exp\left(\frac{A|g_0 - g_{0,c}|^{\alpha}}{T'}\right),
$$
 (1)

where A is a T-independent constant and α , γ are new exponents. The rationale for this modified form is that it arises due to the flow of the current that averages over insulating links with a distribution of different gap sizes at low temperatures, and is controlled by the critical resistors at high temperatures. We note that α and γ need *not* be equal to the expectations from the clean theory, with $\alpha = \nu z$ and $\gamma = 1$, respectively. In Fig. [3\(f\)](#page-3-0), by plotting $[T^{\gamma} \ln(R/R_c)]$ as a function of $|g_0 - g_{0,c}|$, we demonstrate that the above form describes the experimental data [[2](#page-4-1)] as well as our numerical results (inset) on the insulating side over an extended range of temperatures. Remarkably, we find that choosing $\gamma \approx 1.3$ leads to a collapse of all the curves over a wide range of temperature with $\alpha \approx 0.95$ for both the experimental and numerical data.

Outlook.—Our Letter illustrates that a minimal model of long-wavelength disorder-induced smearing of a continuous bandwidth-tuned MIT at half filling can account for a number of mysteries associated with recent transport experiments [\[2\]](#page-4-1). However, a number of questions remain. For instance, the experiments report evolution of the spin susceptibility across the same transition and as a function of temperature. Since the low-temperature susceptibility does not change significantly across the transition, even within a percolation-based picture the susceptibility for the insulating puddles should be comparable to the metallic puddles. If this is not the case, the decreasing fraction of metallic puddles below p_c would lead to a decreasing susceptibility. Similarly, the temperature-dependent evolution of the susceptibility, and the associated Pomeranchuk effect, can arise due to the combined effect of temperature dependence from metallic/insulating puddles and the critical puddles. We leave a detailed theoretical modeling of these observations for future Letter. Future measurements of the local compressibility and NMR will lead to further insights into the mesoscale inhomogeneities near the MIT. These experiments likely also hold the key for explaining the origin of the difference in the behavior of electrical transport near a similar continuous MIT, but in a moiré TMD homobilayer [\[1\]](#page-4-0).

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results in the absence of thermal activation, complementary results obtained using effective medium theory, an approximate estimate of the disorder strength, and experimental considerations for recovering an effective activated form of transport in the insulator.

[23] The variations in local twist angle and the size of the moiré unit cell can also induce chemical-potential disorder. However, we will consider the simpler situation with only a local bandwidth disorder, which already helps us address the experimental puzzles.